TEST REPORT

Reference No. : WTS17S0270516E

FCC ID...... : 2AIO2-DK10

Applicant : Dellking Industrial Co., Ltd

Address 2F, Building D, No 3, Ganli 2nd Road, Buji, Longgang District,

Shenzhen, China

Manufacturer : Dellking Industrial Co., Ltd

Shenzhen, China

Product Name : Bluetooth Helmet Headset

Model No. : DK10

Date of Receipt sample : Feb. 14, 2017

Date of Test...... : Feb. 15 – Feb. 26, 2017

de Z

Date of Issue : Feb. 27, 2017

Test Result Pass

Remarks:

The results shown in this test report refer only to the sample(s) tested, this test report cannot be reproduced, except in full, without prior written permission of the company. The report would be invalid without specific stamp of test institute and the signatures of compiler and approver.

Prepared By: Waltek Services (Shenzhen) Co., Ltd.

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Tested by:

Approved by:

Philo Zhong / Manager

Zero Zhou / Test Engineer

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3 Revision History

Test report No.	Date of Receipt sample	Date of Test	Date of Issue	Purpose	Comment	Approved
WTS17S0270516E	Feb. 14, 2017	Feb. 15 – Feb. 26, 2017	Feb. 27, 2017	original	-	Valid

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4 General Information

4.1 General Description of E.U.T.

Product Name : Bluetooth Helmet Headset

Model No. : DK10

Operation Frequency: 2402-2480MHz, 79(EDR) Channels in total

Bluetooth Version : 3.0

The Lowest Oscillator :16MHz

Antenna Gain : 0dBi

Type of Modulation: GFSK, Pi/4DQPSK, 8DPSK

Antenna installation : Ceramic Antenna

4.2 Details of E.U.T.

Technical Data: DC 3.7V, 150mAh, power by battery

Charging: DC 5V, 75mA by USB port from PC

4.3 Channel List

EDR

Channel No.	Frequency (MHz)	Channel No.	Frequency (MHz)	Channel No.	Frequency (MHz)	Channel No.	Frequency (MHz)
1	2402	2	2403	3	2404	4	2405
5	2406	6	2407	7	2408	8	2409
9	2410	10	2411	11	2412	12	2413
13	2414	14	2415	15	2416	16	2417
17	2418	18	2419	19	2420	20	2421
21	2422	22	2423	23	2424	24	2425
25	2426	26	2427	27	2428	28	2429
29	2430	30	2431	31	2432	32	2433
33	2434	34	2435	35	2436	36	2437
37	2438	38	2439	39	2440	40	2441
41	2442	42	2443	43	2444	44	2445
45	2446	46	2447	47	2448	48	2449
49	2450	50	2451	51	2452	52	2453
53	2454	54	2455	55	2456	56	2457
57	2458	58	2459	59	2460	60	2461
61	2462	62	2463	63	2464	64	2465
65	2466	66	2467	67	2468	68	2469
69	2470	70	2471	71	2472	72	2473
73	2474	74	2475	75	2476	76	2477
77	2478	78	2479	79	2480	-	-

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4.4 Test Mode

All test mode(s) and condition(s) mentioned were considered and evaluated respectively by performing full tests, the worst data were recorded and reported.

Table 1 Tests Carried Out Under FCC part 15.247

Test mode	Low channel	Middle channel	High channel
Transmitting	2402MHz	2441MHz	2480MHz

Table 2 Tests Carried Out Under FCC part 15.207 and 15.209

Test Item	Test Mode		
Radiated Emissions	Charging + Transmitting		
Conducted Emissions	Charging + Transmitting		

4.5 Test Facility

The test facility has a test site registered with the following organizations:

• IC – Registration No.: 7760A

Waltek Services(Shenzhen) Co., Ltd. has been registered and fully described in a report filed with the Industry Canada. The acceptance letter from the Industry Canada is maintained in our files.

Registration 7760A, October 15, 2015

FCC Test Site 1# Registration No.: 880581

Waltek Services(Shenzhen) Co., Ltd. EMC Laboratory `has been registered and fully described in a report filed with the (FCC) Federal Communications Commission. The acceptance letter from the FCC is maintained in our files. Registration 880581, April 29, 2014.

FCC Test Site 2# Registration No.: 328995

Waltek Services(Shenzhen) Co., Ltd. EMC Laboratory `has been registered and fully described in a report filed with the (FCC) Federal Communications Commission. The acceptance letter from the FCC is maintained in our files. Registration 328995, December 3, 2014.

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5 Equipment Used during Test

5.1 Equipments List

	5.1 Equipments							
Conducted Emissions Test Site 1#								
Item	Equipment	Manufacturer	Model No.	Serial No.	Last Calibration Date	Calibration Due Date		
1.	EMI Test Receiver	R&S	ESCI	100947	Sep.12, 2016	Sep.11, 2017		
2.	LISN	R&S	ENV216	101215	Sep.12, 2016	Sep.11, 2017		
3.	Cable	Тор	TYPE16(3.5M)	-	Sep.12, 2016	Sep.11, 2017		
Condu	cted Emissions Test	Site 2#						
Item	Equipment	Manufacturer	Model No.	Serial No.	Last Calibration Date	Calibration Due Date		
1.	EMI Test Receiver	R&S	ESCI	101155	Sep.12, 2016	Sep.11, 2017		
2.	LISN	SCHWARZBECK	NSLK 8128	8128-289	Sep.12, 2016	Sep.11, 2017		
3.	Limiter	York	MTS-IMP-136	261115-001- 0024	Sep.12, 2016	Sep.11, 2017		
4.	Cable	LARGE	RF300	-	Sep.12, 2016	Sep.11, 2017		
3m Ser	mi-anechoic Chamber	for Radiation Emis	sions Test site	1#				
ltem	Equipment	Manufacturer	Model No.	Serial No.	Last Calibration Date	Calibration Due Date		
1	Spectrum Analyzer	R&S	FSP	100091	Apr.29, 2016	Apr.28, 2017		
2	Amplifier	Agilent	8447D	2944A10178	Jan.13, 2016	Jan.12, 2017		
3	Active Loop Antenna	Beijing Dazhi	ZN30900A	0703	Oct.17, 2016	Oct.16, 2017		
4	Trilog Broadband Antenna	SCHWARZBECK	VULB9163	33 6	Apr.09, 2016	Apr.08, 2017		
5	Coaxial Cable (below 1GHz)	Тор	TYPE16(13M)	-	Sep.12, 2016	Sep.11, 2017		
6	Broad-band Horn Antenna	SCHWARZBECK	BBHA 9120 D	667	Apr.09, 2016	Apr.08, 2017		
7	Broadband Preamplifier	COMPLIANCE DIRECTION	PAP-1G18	2004	Apr.13, 2016	Apr.12, 2017		
8	Coaxial Cable (above 1GHz)	Тор	1GHz-18GHz	EW02014-7	Apr.13, 2016	Apr.12, 2017		
3m Ser	mi-anechoic Chamber	for Radiation Emis	ssions Test site	2#				
Item	Equipment	Manufacturer	Model No.	Serial No	Last Calibration Date	Calibration Due Date		
1	Test Receiver	R&S	ESCI	101296	Apr.13, 2016	Apr.12, 2017		
2	Trilog Broadband Antenna	SCHWARZBECK	VULB9160	9160-3325	Apr.09, 2016	Apr.08, 2017		
3	Amplifier	ANRITSU	MH648A	M43381	Apr.13, 2016	Apr.12, 2017		
4 Cable HUBER+SUHNER CBL2 525178 Apr.13, 2016 Apr.12, 2017								

Item	Equipment	Manufacturer	Model No.	Serial No.	Last Calibration Date	Calibration Due Date
1.	EMC Analyzer (9k~26.5GHz)	Agilent	E7405A	MY45114943	Sep.12, 2016	Sep.11, 2017
2.	Spectrum Analyzer (9k-6GHz)	R&S	FSL6	100959	Sep.12, 2016	Sep.11, 2017
3.	Signal Analyzer (9k~26.5GHz)	Agilent	N9010A	MY50520207	Sep.12, 2016	Sep.11, 2017

5.2 Measurement Uncertainty

Parameter	Uncertainty
Radio Frequency	± 1 x 10 ⁻⁶
RF Power	± 1.0 dB
RF Power Density	± 2.2 dB
	± 5.03 dB (30M~1000MHz)
Radiated Spurious Emissions test	± 5.47 dB (1000M~25000MHz)
Conducted Spurious Emissions test	± 3.64 dB (AC mains 150KHz~30MHz)

5.3 Test Equipment Calibration

All the test equipments used are valid and calibrated by CEPREI Certification Body that address is No.110 Dongguan Zhuang RD. Guangzhou, P.R.China.

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6 Test Summary

Test Items	Test Requirement	Result		
Conduct Emission	15.207	С		
	15.205(a)			
Spurious Radiated Emissions	15.209	С		
	15.247(d)			
Dond adea	15.247(d)	0		
Band edge	15.205(a)	С		
Bandwidth	15.247(a)(1)	С		
Maximum Peak Output Power	15.247(b)(1)	С		
Frequency Separation	15.247(a)(1)	С		
Number of Hopping Frequency	15.247(a)(1)(iii)	С		
Dwell time	15.247(a)(1)(iii)	С		
SAR	1.1307(b)(1)	С		
Antenna Requirement	15.203	С		
Note: C=Compliance; NC=Not Compliance; NT=Not Tested; N/A=Not Applicable.				

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7 Conducted Emission

Test Requirement: FCC CFR 47 Part 15 Section 15.207
Test Method: ANSI C63.10:2013;ANSI C63.4:2014

Test Result: PASS

Frequency Range: 150kHz to 30MHz

Class/Severity: Class B

Limit: Free

Fraguenov (MHz)	Conducted Limit (dBµV)			
Frequency (MHz)	Qsi-peak	Average		
0.15 to 0.5	66 to 56*	56 to 46*		
0.5 to 5.0	56	46		
5.0 to 30	60	50		
*Decreases with the logarithm of the frequency.				

7.1 E.U.T. Operation

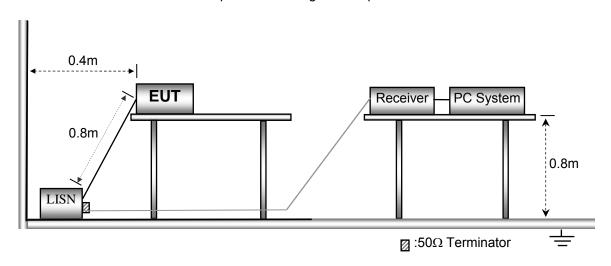
Operating Environment:

Temperature: 22.8 °C
Humidity: 52.6 % RH
Atmospheric Pressure: 101.2kPa

EUT Operation : Refer to Section 4.4.

7.2 EUT Setup

The conducted emission tests were performed using the setup accordance with the ANSI C63.10:2013.



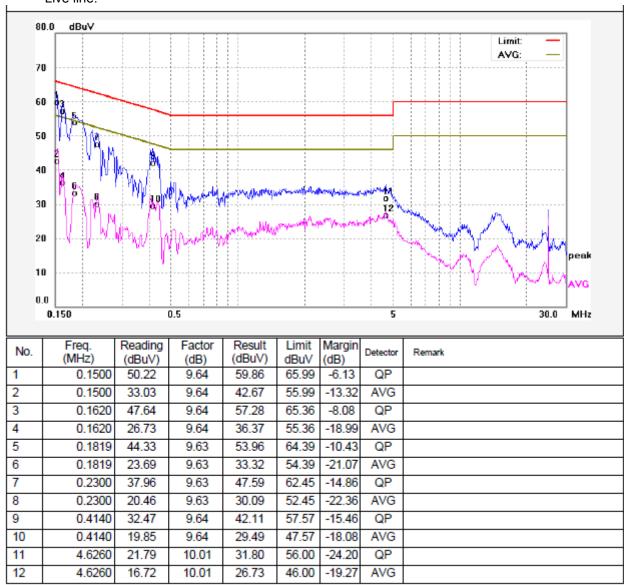
7.3 Measurement Description

The maximised peak emissions from the EUT was scanned and measured for both the Live and Neutral Lines. Quasi-peak & average measurements were performed if peak emissions were within 6dB of the average limit line.

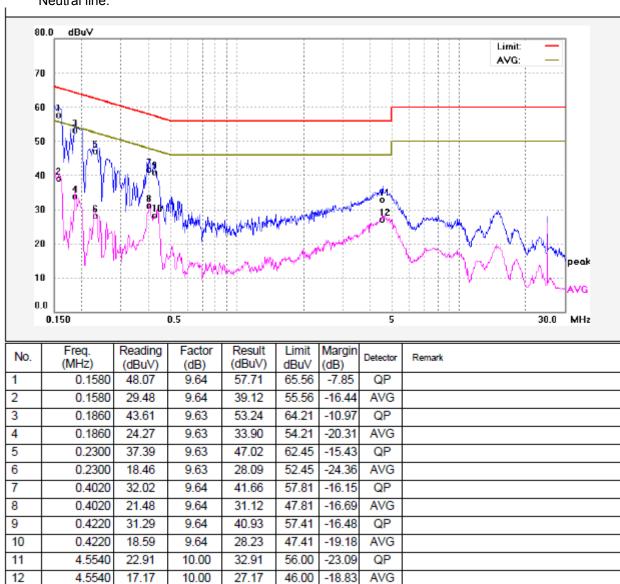
7.4 Conducted Emission Test Result

An initial pre-scan was performed on the live and neutral lines.

Live line:



Neutral line:



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8 Radiated Emissions

Test Requirement: FCC CFR47 Part 15 Section 15.209 & 15.247

Test Method: ANSI C63.10:2013;ANSI C63.4:2014

Test Result: PASS
Measurement Distance: 3m

Limit:

Enric						
_	Field Strength		Field Strength Limit at 3m Measurement Dist			
Frequency (MHz)	uV/m	Distance (m)	uV/m	dBuV/m		
0.009 ~ 0.490	2400/F(kHz)	300	10000 * 2400/F(kHz)	20log ^{(2400/F(kHz))} + 80		
0.490 ~ 1.705	24000/F(kHz)	30	100 * 24000/F(kHz)	20log ^{(24000/F(kHz))} + 40		
1.705 ~ 30	30	30	100 * 30	20log ⁽³⁰⁾ + 40		
30 ~ 88	100	3	100	20log ⁽¹⁰⁰⁾		
88 ~ 216	150	3	150	20log ⁽¹⁵⁰⁾		
216 ~ 960	200	3	200	20log ⁽²⁰⁰⁾		
Above 960	500	3	500	20log ⁽⁵⁰⁰⁾		

8.1 EUT Operation

Operating Environment:

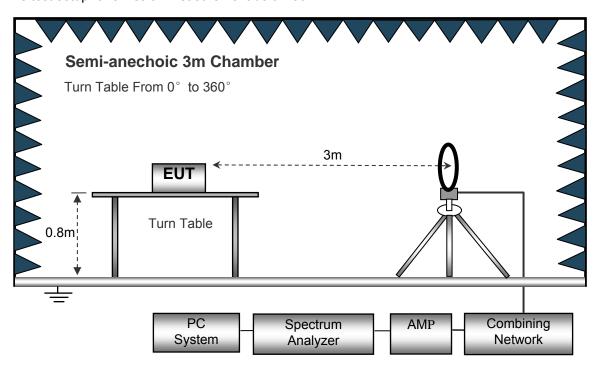
Temperature: 23.5 °C
Humidity: 52.1 % RH
Atmospheric Pressure: 101.2kPa

EUT Operation : Refer to Section 4.4.

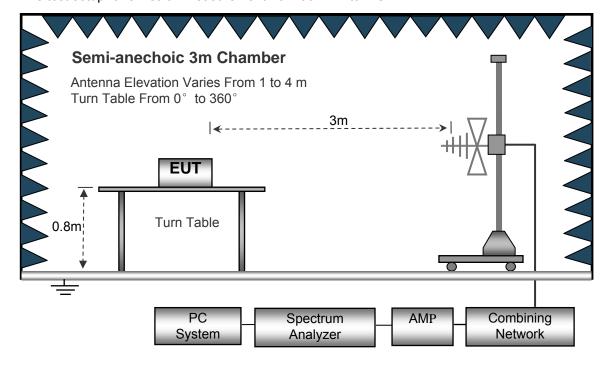
8.2 Test Setup

The radiated emission tests were performed in the 3m Semi- Anechoic Chamber test site, using the setup accordance with the ANSI C63.10: 2013.

The test setup for emission measurement below 30MHz.



The test setup for emission measurement from 30 MHz to 1 GHz.



Anechoic 3m Chamber

Antenna Elevation Varies From 1 to 4 m
Turn Table From 0° to 360°

Turn Table

Absorbers

PC
System
Analyzer

AMP
Combining
Network

The test setup for emission measurement above 1 GHz.

8.3 Spectrum Analyzer Setup

Below 30MHz		
	Sweep Speed	. Auto
	IF Bandwidth	.10kHz
	Video Bandwidth	.10kHz
	Resolution Bandwidth	.10kHz
30MHz ~ 1GH	z	
	Sweep Speed	. Auto
	Detector	.PK
	Resolution Bandwidth	.100kHz
	Video Bandwidth	.300kHz
Above 1GHz		
	Sweep Speed	. Auto
	Detector	.PK
	Resolution Bandwidth	.1MHz
	Video Bandwidth	.3MHz
	Detector	.Ave.
	Resolution Bandwidth	.1MHz
	Video Bandwidth	.10Hz

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8.4 Test Procedure

1. The EUT is placed on a turntable. For below 1GHz, the EUT is 0.8m above ground plane; For above1GHz, the EUT is 1.5m above ground plane.

- 2. The turntable shall be rotated for 360 degrees to determine the position of maximum emission level.
- 3. EUT is set 3m away from the receiving antenna, which is moved from 1m to 4m to find out the maximum emissions. The spectrum was investigated from the lowest radio frequency signal generated in the device, without going below 9 kHz, up to the tenth harmonic of the highest fundamental frequency or to 40 GHz, whichever is lower.
- 4. Maximum procedure was performed on the six highest emissions to ensure EUT compliance.
- 5. And also, each emission was to be maximized by changing the polarization of receiving antenna both horizontal and vertical.
- 6. Repeat above procedures until the measurements for all frequencies are complete.
- 7. The radiation measurements are tested under 3-axes(X,Y,Z) position(X denotes lying on the table, Y denotes side stand and Z denotes vertical stand), After pre-test, It was found that the worse radiation emission was get at the X position. So the data shown was the X position only.

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8.5 Summary of Test Results

Test Frequency: 16MHz ~ 30MHz

The measurements were more than 20 dB below the limit and not reported.

Test Frequency: 30MHz ~ 18GHz

Frequency Receive	Receiver	ceiver Detector	Turn table	RX Antenna		Corrected	O a mar a ta d	FCC Part 15.247/209/205	
Frequency	Reading	Detector	Angle	Height	Polar	Factor	Corrected - Amplitude	Limit	Margin
(MHz)	(dBµV)	(PK/QP/Ave)	Degree	(m)	(H/V)	(dB)	(dBµV/m)	(dBµV/m)	(dB)
	GFSK Low Channel 2402MHz								
268.22	32.56	QP	17	1.7	Н	-13.35	19.21	43.53	-24.32
268.22	26.97	QP	62	1.7	V	-13.35	13.62	43.53	-29.91
4804.00	47.30	PK	339	1.2	V	-1.08	46.22	74.00	-27.78
4804.00	46.94	Ave	339	1.2	V	-1.08	45.86	54.00	-8.14
7206.00	50.95	PK	235	1.7	Н	1.34	52.29	74.00	-21.71
7206.00	43.13	Ave	235	1.7	Н	1.34	44.47	54.00	-9.53
2320.20	46.41	PK	265	1.4	V	-13.20	33.21	74.00	-40.79
2320.20	37.50	Ave	265	1.4	V	-13.20	24.30	54.00	-29.70
2356.75	44.74	PK	197	1.7	Н	-13.12	31.62	74.00	-42.38
2356.75	36.34	Ave	197	1.7	Н	-13.12	23.22	54.00	-30.78
2487.82	44.53	PK	259	1.9	V	-13.02	31.51	74.00	-42.49
2487.82	37.85	Ave	259	1.9	V	-13.02	24.83	54.00	-29.17

Receiver	er – .	Turn	RX Antenna		Corrected		FCC Part 15.247/209/205		
Frequency	Reading	Detector	table Angle	Height	Polar	Factor	Corrected - Amplitude	Limit	Margin
(MHz)	(dBµV)	(PK/QP/Ave)	Degree	(m)	(H/V)	(dB)	(dBµV/m)	(dBµV/m)	(dB)
	GFSK Middle Channel 2441MHz								
268.22	21.99	QP	147	1.7	Н	-13.35	8.64	43.53	-34.89
268.22	19.99	QP	4	1.3	V	-13.35	6.64	43.53	-36.89
4882.00	52.14	PK	299	1.4	V	-0.62	51.52	74.00	-22.48
4882.00	41.66	Ave	299	1.4	V	-0.62	41.04	54.00	-12.96
7323.00	52.32	PK	344	2.0	Н	2.21	54.53	74.00	-19.47
7323.00	43.56	Ave	344	2.0	Н	2.21	45.77	54.00	-8.23
2337.23	45.24	PK	177	1.2	V	-13.19	32.05	74.00	-41.95
2337.23	37.40	Ave	177	1.2	V	-13.19	24.21	54.00	-29.79
2353.57	43.38	PK	115	1.9	Н	-13.14	30.24	74.00	-43.76
2353.57	36.12	Ave	115	1.9	Н	-13.14	22.98	54.00	-31.02
2487.09	44.11	PK	269	1.3	V	-13.08	31.03	74.00	-42.97
2487.09	38.72	Ave	269	1.3	V	-13.08	25.64	54.00	-28.36

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Receiver	ver Datasta	Turn	RX Antenna		Corrected		FCC Part 15.247/209/205		
Frequency	Reading	Detector	table Angle	Height	Polar	Factor	ctor Corrected Amplitude	Limit	Margin
(MHz)	(dBµV)	(PK/QP/Ave)	Degree	(m)	(H/V)	(dB)	(dBµV/m)	(dBµV/m)	(dB)
	GFSK High Channel 2480MHz								
268.22	21.08	QP	89	1.2	Н	-13.35	7.73	43.53	-35.80
268.22	20.89	QP	19	1.3	V	-13.35	7.54	43.53	-35.99
4960.00	52.35	PK	70	1.0	V	-0.24	52.11	74.00	-21.89
4960.00	40.43	Ave	70	1.0	V	-0.24	40.19	54.00	-13.81
7440.00	53.99	PK	18	1.1	Н	2.84	56.83	74.00	-17.17
7440.00	43.01	Ave	18	1.1	Н	2.84	45.85	54.00	-8.15
2312.41	46.80	PK	46	1.8	V	-13.19	33.61	74.00	-40.39
2312.41	38.40	Ave	46	1.8	V	-13.19	25.21	54.00	-28.79
2374.73	42.36	PK	204	1.9	Н	-13.14	29.22	74.00	-44.78
2374.73	37.28	Ave	204	1.9	Н	-13.14	24.14	54.00	-29.86
2493.17	44.24	PK	343	1.2	V	-13.08	31.16	74.00	-42.84
2493.17	38.01	Ave	343	1.2	V	-13.08	24.93	54.00	-29.07

Test Frequency: 18GHz~25GHz

The measurements were more than 20 dB below the limit and not reported.

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9 Band Edge Measurement

Test Requirement: Section 15.247(d) In addition, radiated emissions which fall in the

restricted bands. as defined in Section 15.205(a), must also comply with the radiated emission limits specified in Section 15.209(a) (see

Section 15.205(c)).

Test Method: ANSI C63.10

Test Limit: Regulation 15.247 (d), In any 100 kHz bandwidth outside the

frequency band in which the spread spectrum or digitally modulated intentional radiator is operating, the radio frequency power that is produced by the intentional radiator shall be at least 20 dB below that in the 100 kHz bandwidth within the band that contains the highest level of the desired power, based on either an RF conducted or a radiated measurement, provided the transmitter demonstrates compliance with the peak conducted power limits. If the transmitter complies with the conducted power limits based on the use of RMS averaging over a time interval, as permitted under paragraph (b)(3) of this section, the attenuation required under this paragraph shall be 30 dB instead of 20 dB. Attenuation below the general limits specified in §15.209(a) is not required. In addition, radiated emissions which fall in the restricted bands, as defined in §15.205(a), must also comply with the radiated emission limits specified in §15.209(a) (see §15.205(c)).

Test Mode: Transmitting

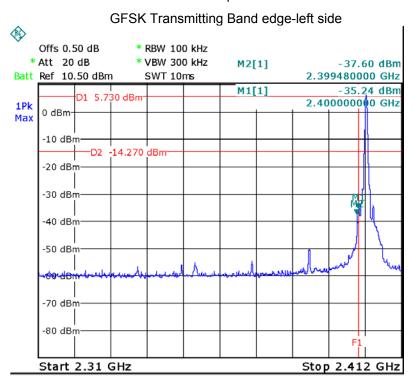
9.1 Test Procedure

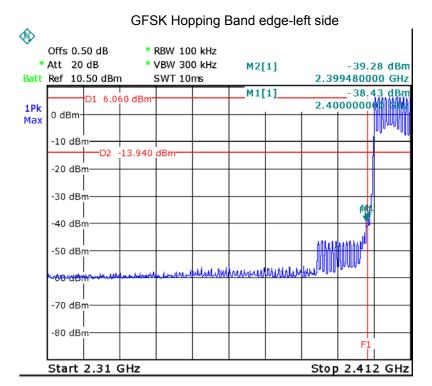
 Remove the antenna from the EUT and then connect a low RF cable from the antenna port to the spectrum;

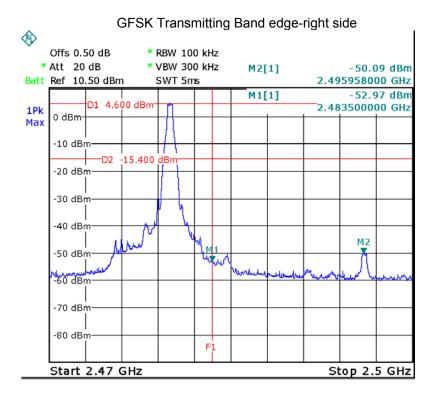
2. Set the spectrum analyzer: RBW = 100kHz, VBW = 300kHz, Sweep = auto Detector function = peak, Trace = max hold

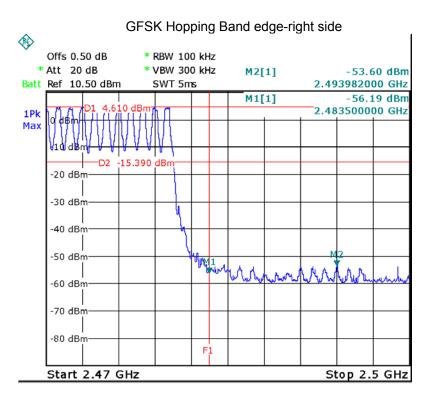
9.2 Test Result:

Test plots

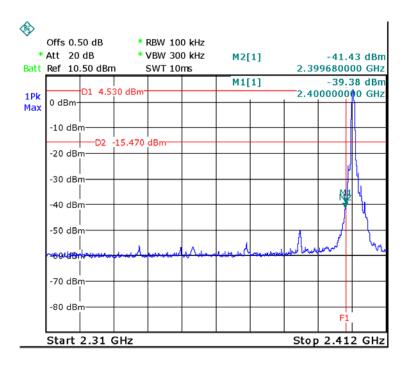




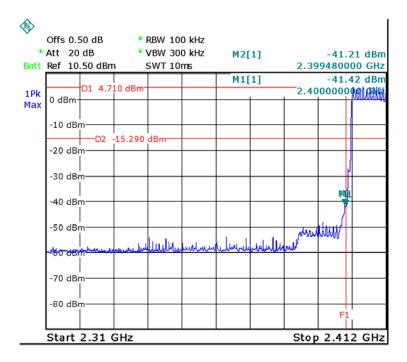




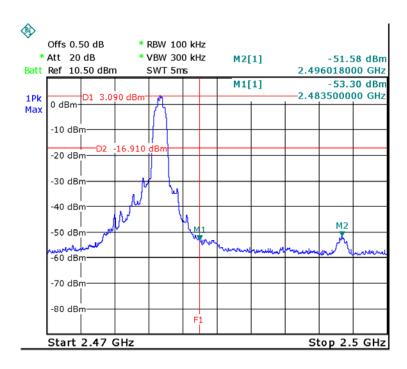
Pi/4 DQPSK Transmitting Band edge-left side



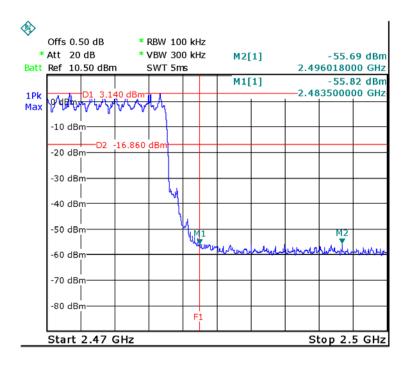
Pi/4 DQPSK Hopping Band edge-left side



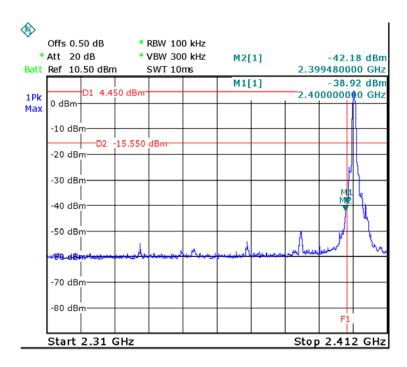
Pi/4 DQPSK Transmitting Band edge-right side



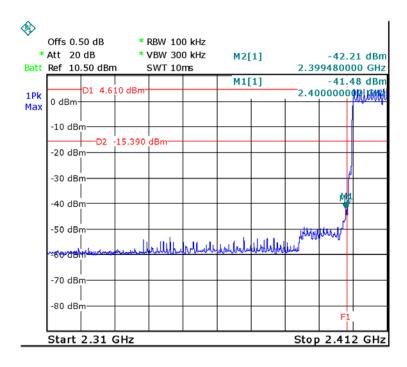
Pi/4 DQPSK Hopping Band edge-right side



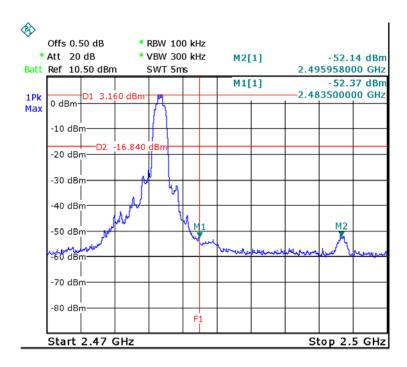
8DPSK Transmitting Band edge-left side



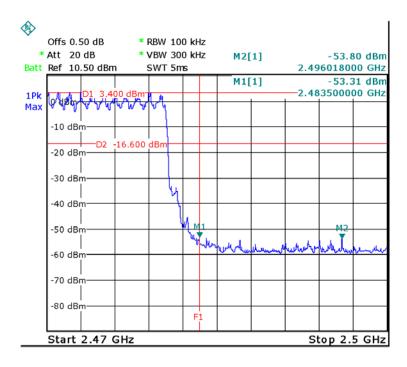
8DPSK Hopping Band edge-left side



8DPSK Transmitting Band edge-right side



8DPSK Hopping Band edge-right side



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10 Bandwidth Measurement

Test Requirement: FCC CFR47 Part 15 Section 15.247

Test Method: C63.10: 2013

Test Mode: Test in fixing operating frequency at low, Middle, high channel.

10.1 Test Procedure:

1. Remove the antenna from the EUT and then connect a low RF cable from the antenna port to the spectrum;

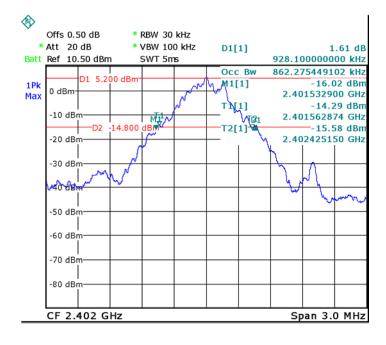
2. Set the spectrum analyzer: RBW = 30kHz, VBW = 100kHz

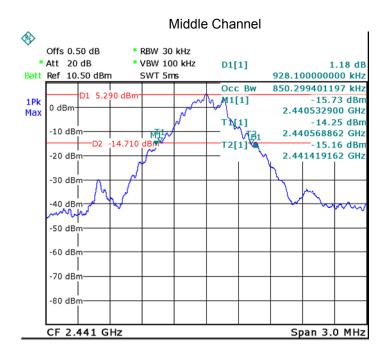
10.2 Test Result:

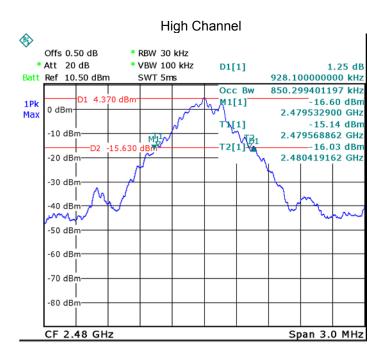
Modulation	Test Channel	20 dB Bandwidth	99% Bandwidth	
GFSK	Low	0.928MHz	0.862MHz	
GFSK	Middle	0.928MHz	0.850MHz	
GFSK	High	0.928MHz	0.850MHz	
Pi/4 DQPSK	Low	1.258MHz	1.186MHz	
Pi/4 DQPSK	Pi/4 DQPSK Middle		1.180MHz	
Pi/4 DQPSK	High	1.258MHz	1.174MHz	
8DPSK	Low	1.264MHz	1.180MHz	
8DPSK	Middle	1.264MHz	1.180MHz	
8DPSK	High	1.264MHz	1.168MHz	

Test result plot as follows:

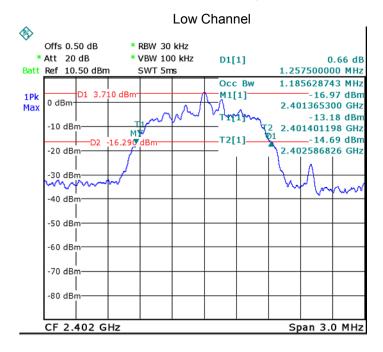
Modulation: GFSK Low Channel

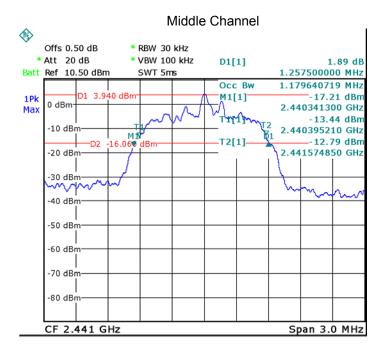


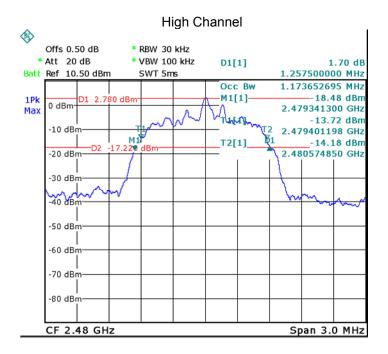




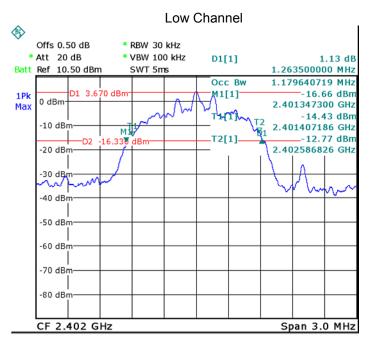
Modulation: Pi/4 DQPSK

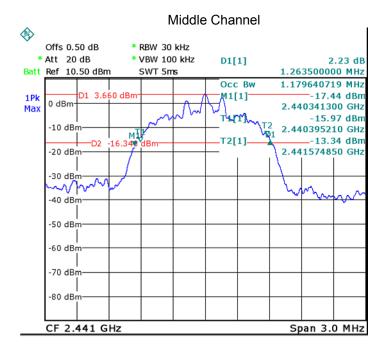


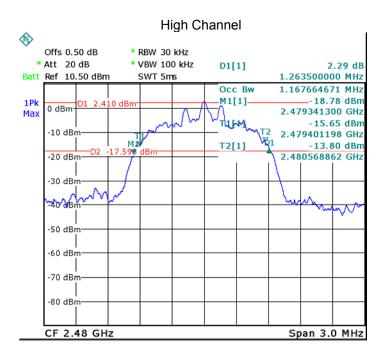




Modulation: 8DPSK







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11 Maximum Peak Output Power

Test Requirement: FCC CFR47 Part 15 Section 15.247

Test Method: C63.10:2013

Test Limit: Regulation 15.247 (b)(1), For frequency hopping systems

operating in the 2400-2483.5 MHz band employing at least 75 non-overlapping hopping channels, and all frequency hopping systems in the 5725-5850 MHz band: 1 watt. For all other frequency hopping systems in the 2400-2483.5 MHz band:

0.125 watts.

Refer to the result "Number of Hopping Frequency" of this

document. The 1watts (30 dBm) limit applies.

Test mode: Test in fixing frequency transmitting mode.

11.1 Test Procedure:

1. Remove the antenna from the EUT and then connect a low RF cable from the antenna port to the spectrum.

2. Set the spectrum analyzer: RBW = 3 MHz. VBW =3 MHz. Sweep = auto; Detector Function = Peak.

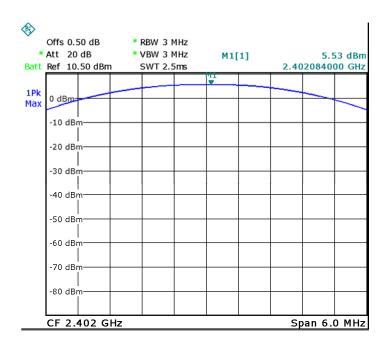
3. Keep the EUT in transmitting at lowest, medium and highest channel individually. Record the max value.

11.2 Test Result:

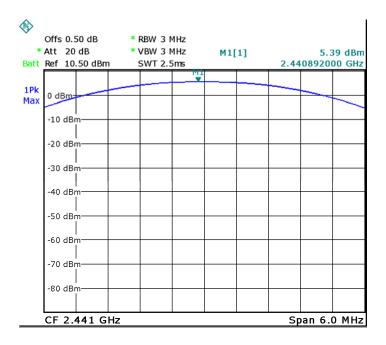
	Data	Pea			
Test Mode	Data Rate	Low Channel	Middle Channel	High Channel	Limit (dBm)
GFSK	1Mbps	5.53	5.39	4.48	20.97
4*π4DQPSK	2Mbps	4.80	4.66	3.49	20.97
8DPSK	3Mbps	4.94	4.87	3.73	20.97

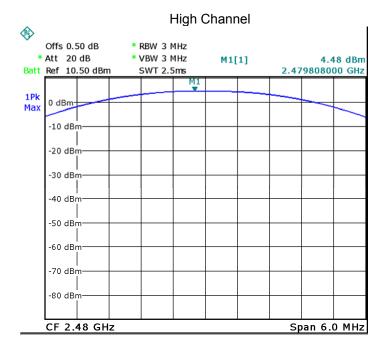
Test result plot as follows:

Modulation: GFSK
Low Channel

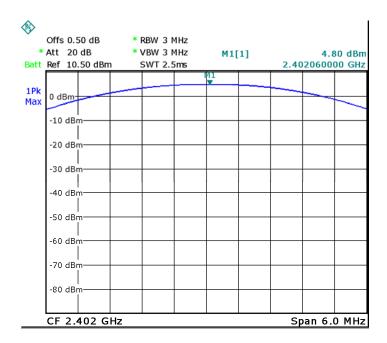


Middle Channel

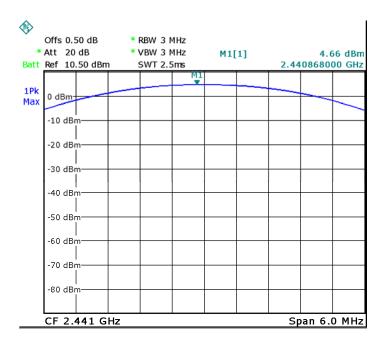


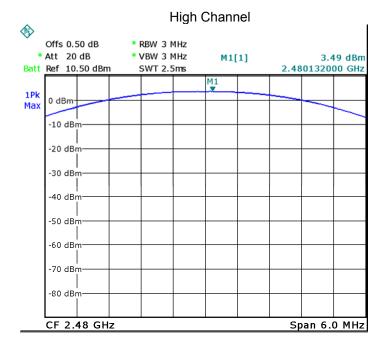


Modulation: Pi/4 DQPSK Low Channel Low Channel

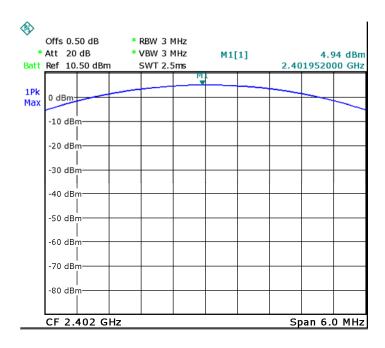


Middle Channel

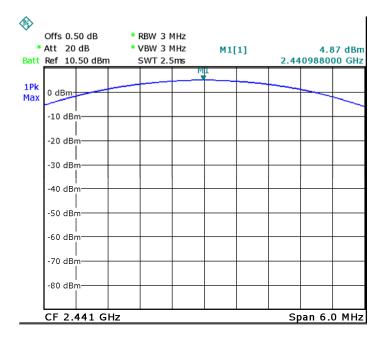


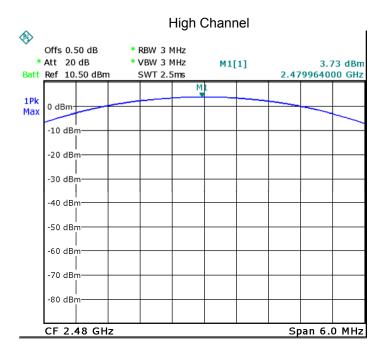


Modulation: 8DPSK Low Channel
Low Channel



Middle Channel





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12 Hopping Channel Separation

Test Requirement: FCC CFR47 Part 15 Section 15.247

Test Method: C63.10:2013

Test Limit: Regulation 15.247(a)(1) Frequency hopping systems shall have

hopping channel carrier frequencies separated by a minimum of 25 kHz or the 20 dB bandwidth of the hopping channel, whichever is greater. Alternatively, frequency hopping systems operating in the 2400-2483.5 MHz band may have hopping channel carrier frequencies that are separated by 25 kHz or two-thirds of the 20 dB bandwidth of the hopping channel, whichever is greater, provided the

systems operate with an output power no greater than 1W.

Test Mode: Test in hopping transmitting operating mode.

12.1 Test Procedure:

1. Remove the antenna from the EUT and then connect a low RF cable from the antenna port to the spectrum.

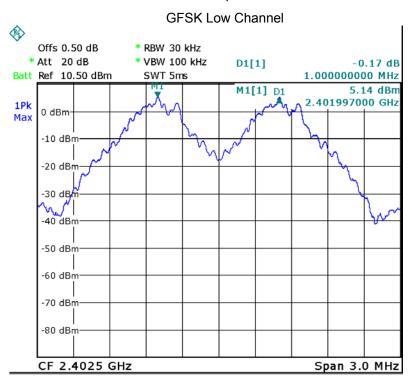
- 2. Set the spectrum analyzer: RBW = 30KHz. VBW = 100KHz , Span = 3MHz. Sweep = auto; Detector Function = Peak. Trace = Max hold.
- 3. Allow the trace to stabilize. Use the marker-delta function to determine the separation between the peaks of the adjacent channels. The limit is specified in one of the subparagraphs of this Section Submit this plot.

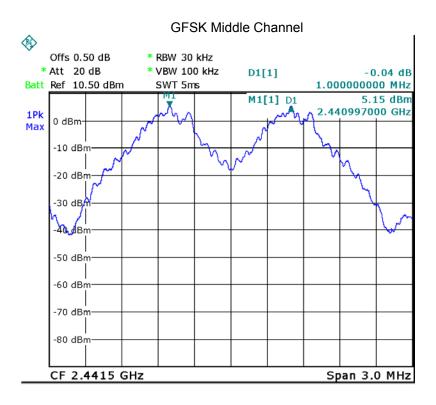
12.2 Test Result:

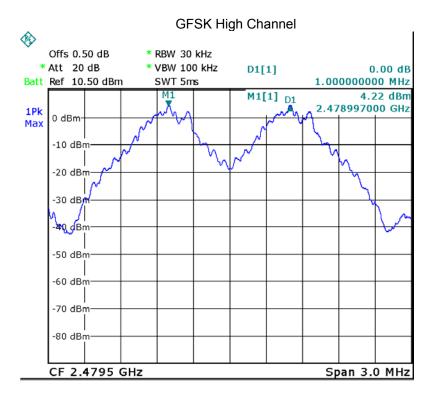
Test result plot as follows:

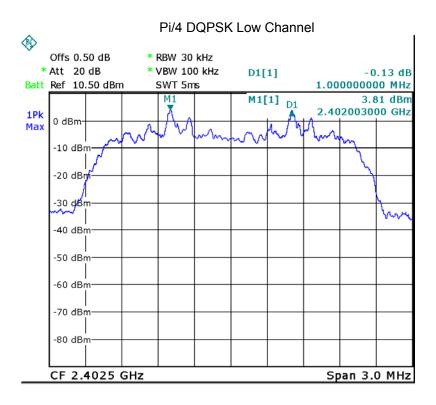
Modulation	Test Channel	Separation (MHz)	Result	
GFSK	Low	1 MHz	PASS	
GFSK	Middle	1 MHz	PASS	
GFSK	High	1 MHz	PASS	
Pi/4 DQPSK	Low	1 MHz	PASS	
Pi/4 DQPSK	Middle	1 MHz	PASS	
Pi/4 DQPSK	High	1 MHz	PASS	
8DPSK	Low	1 MHz	PASS	
8DPSK	Middle	1 MHz	PASS	
8DPSK	High	1 MHz	PASS	

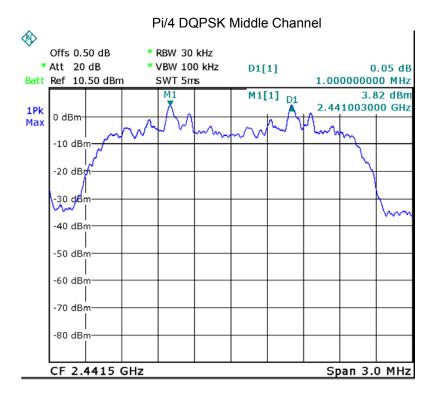
Test plots

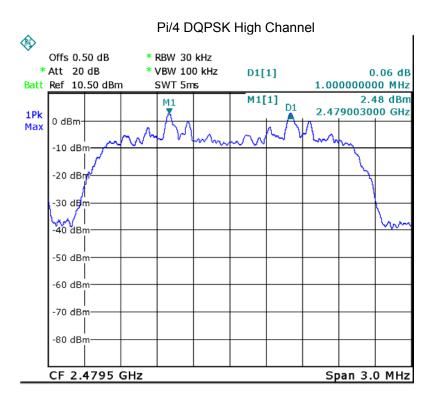


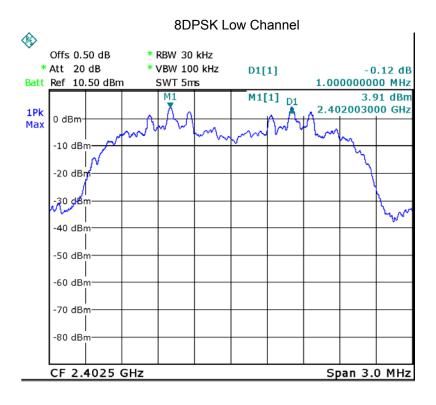


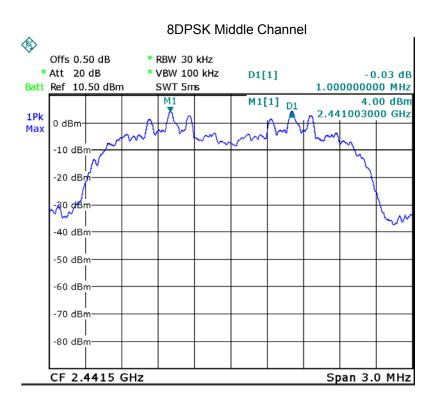


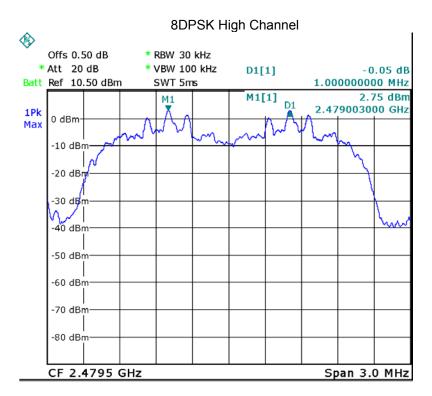












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13 Number of Hopping Frequency

Test Requirement: FCC CFR47 Part 15 Section 15.247

Test Method: C63.10:2013

Test Limit: Regulation 15.247 (a)(1)(iii) Frequency hopping systems in the

2400-2483.5 MHz band shall use at least 15 channels.

Test Mode: Test in hopping transmitting operating mode.

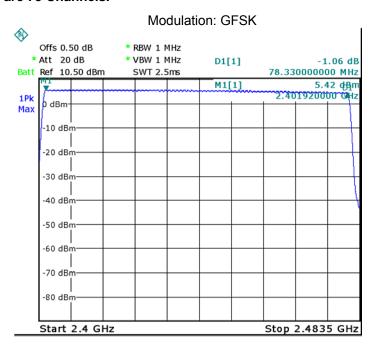
13.1 Test Procedure:

1. Remove the antenna from the EUT and then connect a low RF cable from the antenna port to the spectrum.

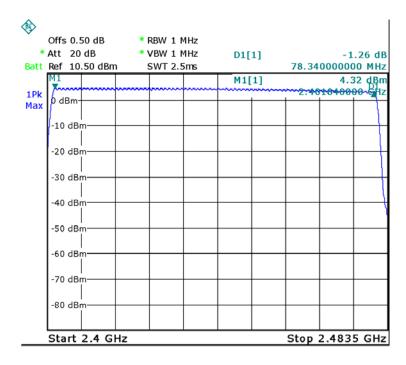
- 2. Set the spectrum analyzer: RBW = 1MHz. VBW = 1MHz. Sweep = auto; Detector Function = Peak. Trace = Max hold.
- 3. Allow the trace to stabilize. It may prove necessary to break the span up to sections. in order to clearly show all of the hopping frequencies. The limit is specified in one of the subparagraphs of this Section.
- 4. Set the spectrum analyzer: Start Frequency = 2.4GHz, Stop Frequency = 2.4835GHz. Sweep=auto;

13.2 Test Result:

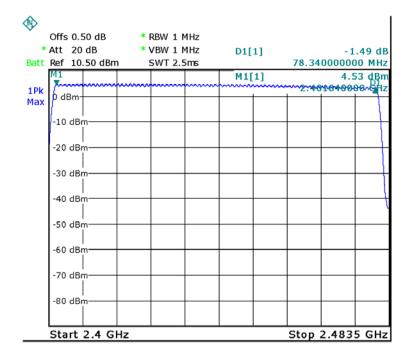
Total Channels are 79 Channels.



Modulation: GFSK Pi/4 DQPSK



Modulation: 8DPSK



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14 Dwell Time

Test Requirement: FCC CFR47 Part 15 Section 15.247

Test Method: C63.10:2013

Test Limit: Regulation 15.247(a)(1)(iii) Frequency hopping systems in

the 2400-2483.5 MHz band shall use at least 15 channels. The average time of occupancy on any channel shall not be greater than 0.4 seconds within a period of 0.4 seconds multiplied by the number of hopping channels employed. Frequency hopping systems may avoid or suppress transmissions on a particular hopping frequency provided that a minimum of 15 channels are

used.

Test Mode: Test in hopping transmitting operating mode.

14.1 Test Procedure:

1.Remove the antenna from the EUT and then connect a low RF cable from the antenna port to the spectrum.

- 2.Set spectrum analyzer span = 0. centred on a hopping channel;
- 3.Set RBW = 1MHz and VBW = 3MHz. Sweep = as necessary to capture the entire dwell time per hopping channel.
- 4.Use the marker-delta function to determine the dwell time. If this value varies with different modes of operation (e.g., data rate, modulation format, etc.), repeat this test for each variation. The limit is specified in one of the subparagraphs of this Section. Submit this plot(s).

14.2 Test Result:

Dwell time = Pulse wide x (Hopping rate / Number of channels) x Period

The test period: T = 0.4(s) * 79 = 31.6(s)

DH5 Packet permit maximum 1600 / 79 / 6 hops per second in each channel (5 time slots RX, 1 time slot TX).

DH3 Packet permit maximum 1600 / 79 / 4 hops per second in each channel (3 time slots RX, 1 time slot TX).

DH1 Packet permit maximum 1600 / 79 / 2 hops per second in each channel (1 time slot RX, 1 time slot TX). So, the Dwell Time can be calculated as follows:

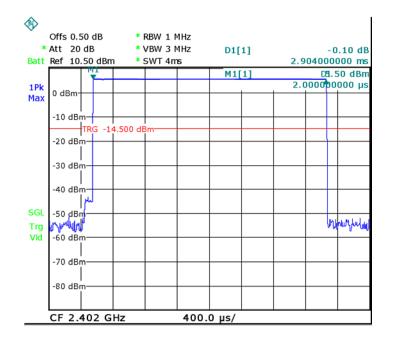
Data Packet	Dwell Time(s)		
DH5	1600/79/6*31.6*(MkrDelta)/1000		
DH3	1600/79/4*31.6*(MkrDelta)/1000		
DH1	1600/79/2*31.6*(MkrDelta)/1000		
Remark	Mkr Delta is single pulse time.		

Modulation	Data Packet	Channel	pulse time(ms)	Dwell Time(s)	Limits(s)
GFSK	DH5	Low	2.904	0.310	0.4
		middle	2.904	0.310	0.4
		High	2.904	0.310	0.4
Pi/4DQPSK	DH5	Low	2.904	0.310	0.4
		middle	2.904	0.310	0.4
		High	2.904	0.310	0.4
8DPSK	DH5	Low	2.904	0.310	0.4
		middle	2.904	0.310	0.4
		High	2.904	0.310	0.4

Modulation: GFSK

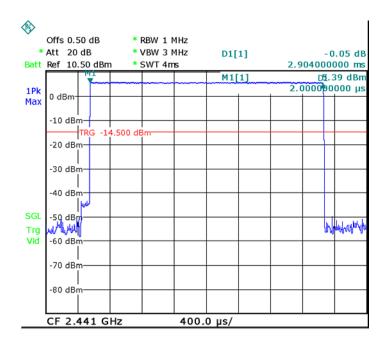
Data Packet:

DH5.Low channel

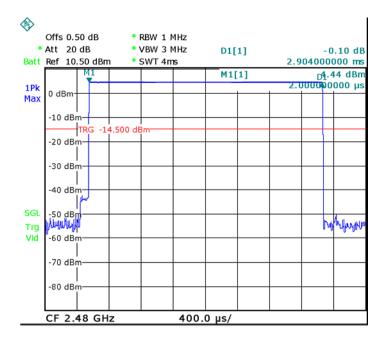


Data Packet:

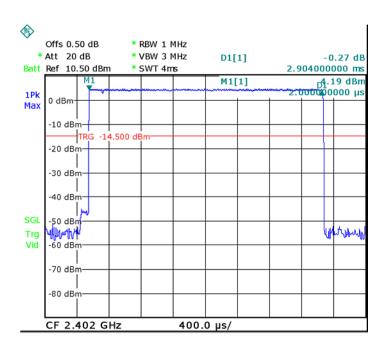
DH5.Middle channel



Data Packet: DH5,High channel

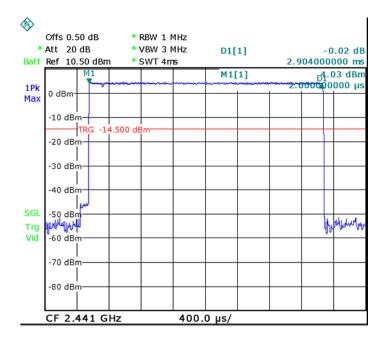


Modulation: Pi/4DQPSK DH5 Data Packet: DH5.Low channel

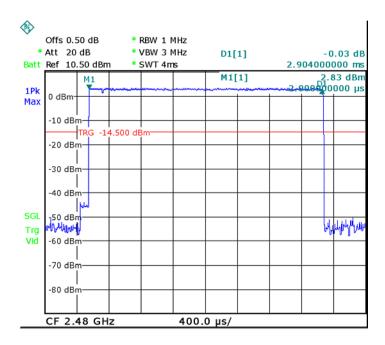


Data Packet:

DH5.Middle channel



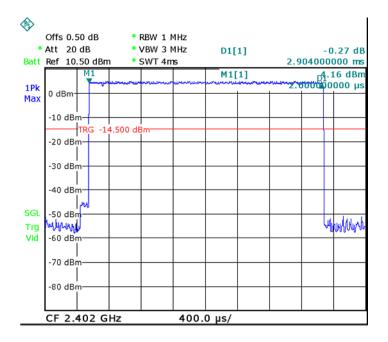
Data Packet: DH5,High channel



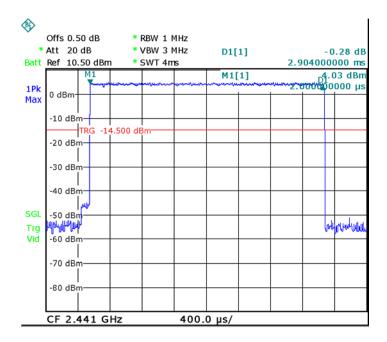
Modulation: 8DPSK DH5

Data Packet:

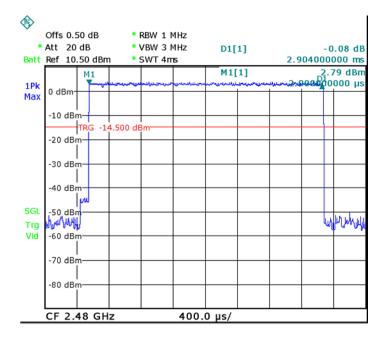
DH5.Low channel



Data Packet: DH5.Middle channel



Data Packet: DH5,High channel



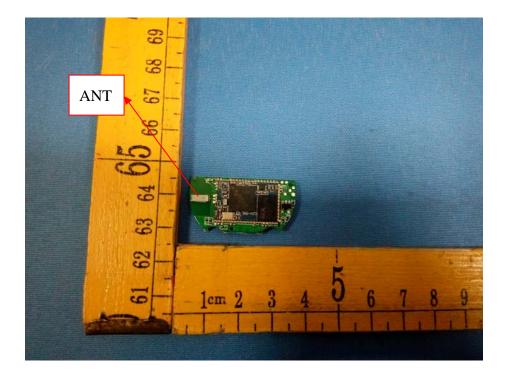
15 Antenna Requirement

An intentional radiator shall be designed to ensure that no antenna other than that furnished by the responsible party shall be used with the device. The use of a permanently attached antenna or of an antenna that uses a unique coupling to the intentional radiator shall be considered sufficient to comply with the provisions of this section. The manufacturer may design the unit so that a broken antenna can be replaced by the user, but the use of a standard antenna jack or electrical connector is prohibited. This requirement does not apply to carrier current devices or to devices operated under the provisions of §15.211, §15.213, §15.217, §15.219, or §15.221. Further, this requirement does not apply to intentional radiators that must be professionally installed, such as perimeter protection systems and some field disturbance sensors, or to other intentional radiators which, in accordance with §15.31(d), must be measured at the installation site. However, the installer shall be responsible for ensuring that the proper antenna is employed so that the limits in this part are not exceeded.

For intentional device, according to FCC 47 CFR Section 15.203, an intentional radiator shall be designed to ensure that no antenna other than that furnished by the responsible party shall be used with the device.

Result:

The EUT has a Ceramic Antenna, the gain is 0dBi. meets the requirements of FCC 15.203.



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16 SAR Evaluation

Test Requirement: FCC Part 1.1307

Evaluation Method: FCC Part2.1093 & KDB 447498 D01 General RF Exposure Guidance v06

16.1 Requirements

1) The 1-g and 10-g SAR test exclusion thresholds for 100 MHz to 6 GHz at test separation distances ≤50 mm are determined by:

[(max. power of channel, including tune-up tolerance, mW)/(min. test separation distance, mm)] • [$\sqrt{f(GHz)}$] \leq 3.0 for 1-g SAR and \leq 7.5 for 10-g extremity SAR where

- 1. f(GHz) is the RF channel transmit frequency in GHz
- 2. Power and distance are rounded to the nearest mW and mm before calculation
- 3. The result is rounded to one decimal place for comparison

The test exclusions are applicable only when the minimum test separation distance is \leq 50 mm and for transmission frequencies between 100 MHz and 6 GHz. When the minimum test separation distance is <5 mm, a distance of 5 mm is applied to determine SAR test exclusion.

16.2 The procedures / limit

Note: No SAR measurement is required.

Remark: Max. duty factor is 100%

Calculation formula: Source-based time-averaged maximum conducted output power (mW)

=Conducted peak power (mW)*Duty factor

For frequency in 2.402GHz: SAR Test Exlusion Thresholds ≤ 3.0 / [√ f(GHz)] *(min. test separation

distance, mm)=3.0/(√2.402) *5=9.679 mW≈10mW

For frequency in 2.480GHz: SAR Test Exlusion Thresholds ≤3.0 / [√ f(GHz)] *(min. test separation

distance, mm)=3.0/(√2.480) *5=9.525 mW≈10mW

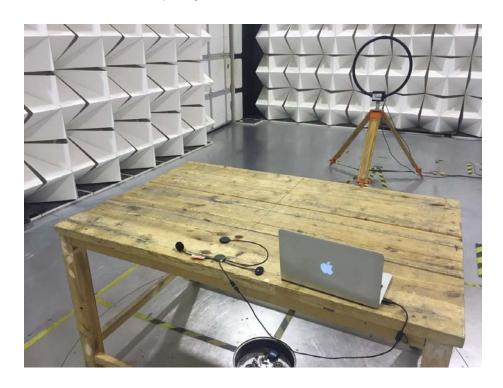
17 Photographs – DK10 Test Setup Photos

17.1 Photograph-Conducted Emissions Test Setup at Test Site 1#



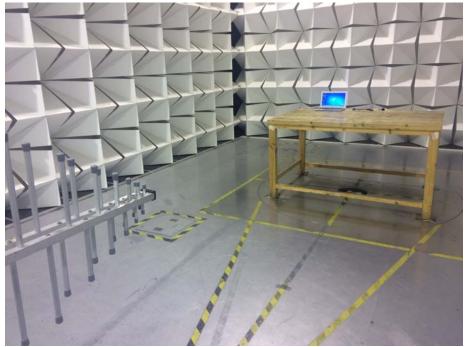
17.2 Photograph-Radiated Emissions

Test Frequency 16MHz to 30MHz at Test Site 2#

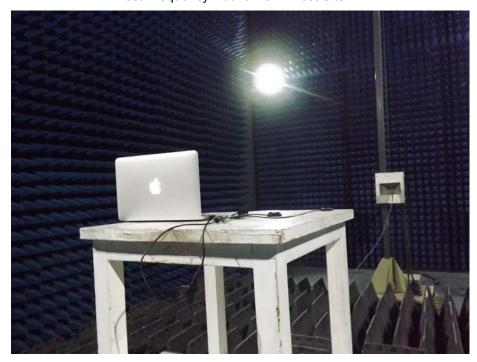


Test Frequency 30MHz to 1000MHz at Test Site 2#





Test Frequency Above 1GHz Test Site 1#





18 Photographs – Constructional Details

18.1 Model DK10- External Photos





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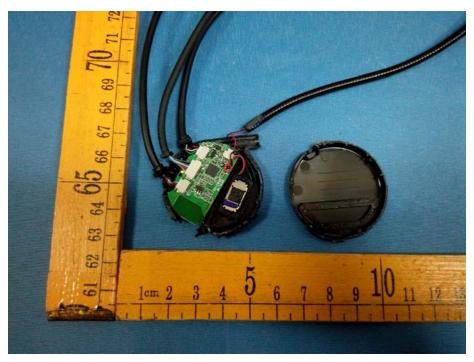


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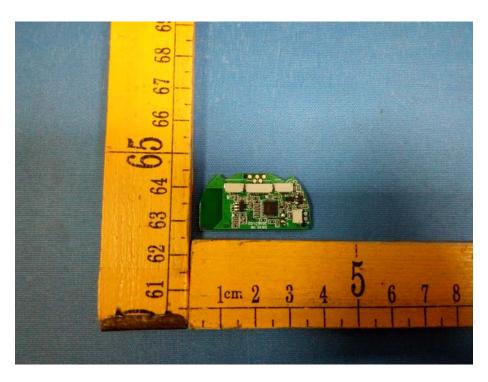


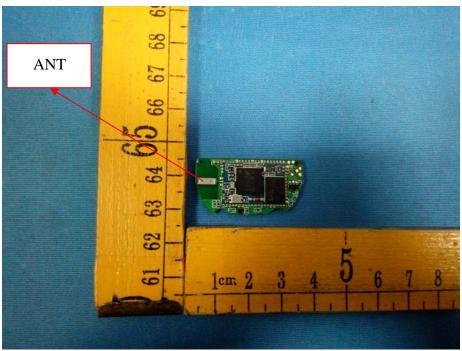


18.2 Model DK10 - Internal Photos

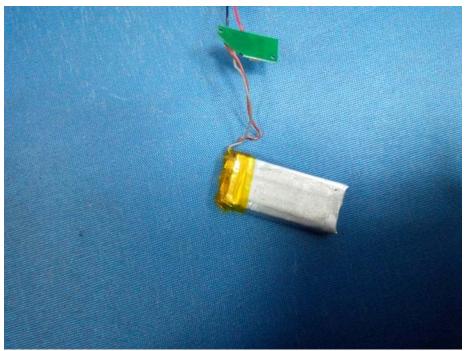












=====End of Report=====